DELIVERY SPECIFICATION

SPEC. No. A-Serial-f

D A T E: Oct., 2021

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Non-Controlled Copy

CUSTOMER'S PRODUCT NAME

TDK PRODUCT NAME

MULTILAYER CERAMIC CHIP CAPACITORS

Bulk and Tape packaging 【RoHS compliant】

CEU3, CEU4 Type (Soft Termination)

Please return this specification to TDK representatives with your signature. If orders are placed without returned specification, please allow us to judge that specification is accepted by your side.

RECEIPT CONFIRMATION

DATE:	YEAR	MONTH	DAY

Test conditions in this specification based on AEC-Q200 for automotive application.

TDK Corporation

Sales Engineering

Electronic Components Electronic Components Business Company Sales & Marketing Group Ceramic Capacitors Business Group

APPROVED	Person in charge	AF

APPROVED	CHECKED	Person in charge

SCOPE

This delivery specification shall be applied to Multilayer ceramic chip capacitors to be delivered to

PRODUCTION PLACES

Production places defined in this specification shall be TDK Corporation, TDK(Suzhou)Co.,Ltd and TDK Components U.S.A.,Inc.

PRODUCT NAME

The name of the product to be defined in this specifications shall be CEU♦♦♦OOO△△□□□×⊚※※※S.

REFERENCE STANDARD

JIS C 5101-1:2010	Fixed capacitors for use in electronic equipment-Part 1: Generic specification
C 5101-22:2014	Fixed capacitors for use in electronic equipment-Part22 : Sectional specification
	: Fixed surface mount multilayer capacitors of ceramic dielectric, Class2
C 0806-3:2014	Packaging of components for automatic handling - Part 3: Packaging of
	surface mount components on continuous tapes
JEITA RCR-2335 C 2014	Safety application guide for fixed ceramic capacitors for use in electronic
	equipment

CONTENTS

- 1. CODE CONSTRUCTION
- 2. OPERATING TEMPERATURE RANGE
- 3. STORING CONDITION AND TERM
- 4. INDUSTRIAL WASTE DISPOSAL
- 5. PERFORMANCE
- 6. INSIDE STRUCTURE AND MATERIAL
- 7. CAUTION FOR PRODUCTS WITH SOFT TERMINATION
- 8. EQUIVALENT CIRCUIT DIAGRAM
- 9. PACKAGING
- 10. CAUTION
- 11. TAPE PACKAGING SPECIFICATION

<EXPLANATORY NOTE>

When the mistrust in the spec arises, this specification is given priority. And it will be confirmed by written spec change after conference of both posts involved.

This specification warrants the quality of the ceramic chip capacitor. Capacitors should be evaluated or confirmed a state of mounted on your product.

If the use of the capacitors goes beyond the bounds of this specification, we can not afford to guarantee.

Division	Date	SPEC. No.
Ceramic Capacitors Business Group	October, 2021	A-Serial-f

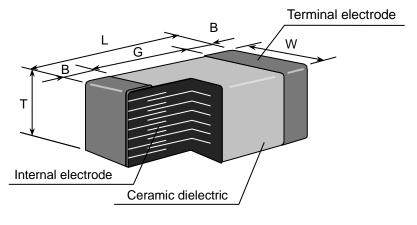
1. CODE CONSTRUCTION

(Example)	CEU	3	Ε	2	X7R	2 A	332	K	Т	***S
	CEU	3	Ε	2	X7R	1 H	223	K	Т	****S
	CEU	4	J	2	X7R	2 A	153	K	Т	****S
	CEU	4	<u>J</u>	2	X7R	<u>1 H</u>	104	<u>K</u>	<u>T</u>	<u> </u>
	(1)	(2)	(3)	(4)	(5)	(6)	(7)	(8)	(9)	(10)

(1) Series

Symbol	Series
CEU	For automotive application Serial design

(2) Case size



Case size	Case size		Dimer	nsions (Unit : mm)	
Symbol	(EIA style)	L	W	T	В	G
3	CEU3 (CC0603)	$1.60^{igoplus 0.20}_{igoplus 0.10}$	$0.80 ^{igoplus 0.15}_{igoplus 0.10}$	$0.80^{+0.15}_{-0.10}$	0.20 min.	0.30 min.
4	CEU4 (CC0805)	$2.00^{igoplus 0.30}_{igoplus 0.20}$	$1.25 ^{+0.25}_{-0.20}$	$1.25 ^{+0.25}_{-0.20}$	0.20 min.	0.50 min.

^{*}As for each item, please refer to detail page on TDK web..

(3) Thickness

Symbol	Dimension(mm)
Е	0.80
J	1.25

(4) Voltage condition in the life test

^{*} Details are shown in table 1 No.15 at 5.PERFORMANCE.

Symbol	Condition
2	Rated Voltage x 2

(5) Temperature Characteristics

(6) Rated Voltage

* Please refer to pages 12 and 13 as the caution about operating voltage.

Symbol	Rated Voltage
2 A	DC 100 V
1 H	DC 50 V

(7) Rated Capacitance

Stated in three digits and in units of pico farads (pF). The first and Second digits identify the first and second significant figures of the capacitance, the third digit identifies the multiplier.

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Symbol	Rated Capacitance
104	100,000 pF

^{*} Details are shown in table 1 No.6 at 5.PERFORMANCE.

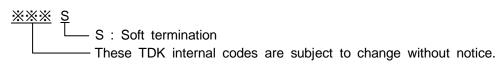
(8) Capacitance tolerance

Symbol	Packaging
K	± 10 %
М	± 20 %

(9) Packaging

Symbol	Packaging
В	Bulk
Т	Taping

(10) TDK internal code



2. OPERATING TEMPERATURE RANGE

T.C.	Min. operating	Max. operating	Reference
	Temperature	Temperature	Temperature
X7R	-55°C	125°C	25°C

3. STORING CONDITION AND TERM

Storing temperature	Storing humidity	Storing term
5~40°C	20~70%RH	Within 6 months upon receipt.

4. INDUSTRIAL WASTE DISPOSAL

Dispose this product as industrial waste in accordance with the Industrial Waste Law.

5. PERFORMANCE

Table 1

		100.0			
No.	Item	Performance	Test or inspection method		
1	External Appearance	No defects which may affect performance.	Inspect with magnifying glass (3x)		
2	Insulation Resistance	10,000MΩ or 500MΩ·μF min. whichever smaller.	Measuring voltage: Rated voltage Voltage application time: 60s.		
3	Voltage Proof	Withstand test voltage without insulation breakdown or other damage.	Apply voltage: 2.5 × rated voltage Voltage application time: 1s. Charge/discharge current: 50mA or lower		
4	Capacitance	Within the specified tolerance.	Measuring Measuring frequency voltage 1kHz±10% 1.0±0.2Vrms		
5	Dissipation Factor	Please refer to detail page on TDK web.	See No.4 in this table for measuring condition.		
6	Temperature Characteristics of Capacitance	Capacitance Change (%) No voltage applied X7R: ± 15	Capacitance shall be measured by the steps shown in the following table after thermal equilibrium is obtained for each step. ΔC be calculated ref. STEP3 reading. Step Temperature(°C) 1 25 ± 2 2 -55 ± 2 3 25 ± 2 4 125 ± 2 As for measuring voltage, please contact with our sales representative.		
7	Robustness of Terminations	No sign of termination coming off, breakage of ceramic, or other abnormal signs.	Reflow solder the capacitors on a P.C.Board shown in Appendix 2. Apply a pushing force gradually at the center of a specimen in a horizontal direction of P.C.board. Pushing force: 17.7N Holding time: 10±1s. 17.7N P.C.Board		

(continued)

No.	It	em	Perfo	ormance	Test of	Test or inspection method	
8	Bending	External appearance	No mechanical	damage.		the capacitors on a own in Appendix. 50 F R230 (Unit : mm	
9	Solderability	/	New solder to termination.	cover over 75% of	Solder :	Sn-3.0Ag-0.5Cu	
			25% may have spots but not c spot.	pin holes or rough concentrated in one	Flux :	Isopropyl alcohol (JIS k 8839) Rosin (JIS K 5902 25% solid solution.	
			Ceramic surface shall not be exp	osed due to	Solder temp. :	245±5°C	
			melting or shifting of termination material. A section		Dwell time :	3±0.3s.	
					Solder position :	Until both terminations are completely soaked.	
10	Resistance	External	No cracks are a		Solder :	Sn-3.0Ag-0.5Cu	
	to solder heat	' '	terminations shall be covered at least 60% with new solder.		Flux :	Isopropyl alcohol (JIS K	
		Capacitance		T		8839) Rosin (JIS K 5902) 25% solid solution.	
			Characteristics	Change from the value before test	Solder temp. :	260±5°C	
			X7R	± 7.5 %	Dwell time :	10±1s.	
					Solder position :	Until both terminations are completely soaked.	
		D.F.	tance			Temp. — 110~140°C	
		Insulation Resistance				Time — $30\sim60$ s.	
		Voltage proof			- ior ∠4±2n bet	ore measurement.	

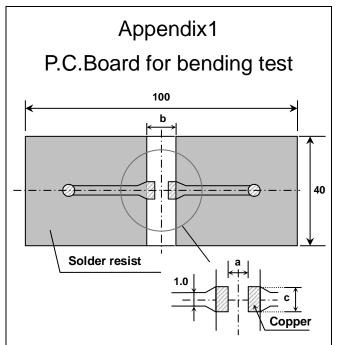
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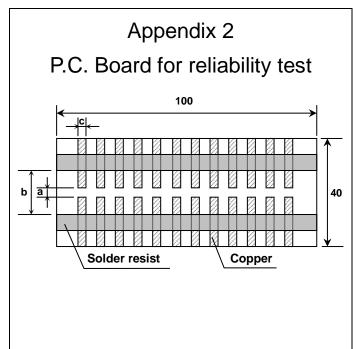
No.	It	em	Performance		Test or inspection method			
11	Vibration	External appearance	No mechanical damage.			Applied force : 5G max. Frequency : 10~2,000Hz		
		Capacitance	Characteristics	Change from the value before test	Reciprocating sweep time: 20 min. Cycle: 12 cycles in each 3 mutually		mutually	
			X7R	± 7.5 %		perpendicular direc	tions.	
		D.F.	Meet the initial spec.		Reflow solder the capacitors on a P.C.Board shown in Appendix 2 before testing.			
12 Temperature cycle		External appearance	No mechanical damage.		step1 th	Expose the capacitors in the condition step1 through step 4 listed in the following table.		
		Capacitance	Characteristics	Change from the value before test	Temp. cycle: 1,000 cycles			
			X7R	Please contact	Step	Temperature(°C)	Time (min.)	
				with our sales representative.	1	-55 ± 3	30 ± 3	
					2	Ambient Temp.	2 ~ 5	
		D.F.	Meet the initial	enac	3	125 ± 2	30 ± 2	
		D.1 .	ividet trie iriitiar	eet the illitial spec.		Ambient Temp.	2 ~ 5	
		Insulation Resistance	Meet the initial spec.			Leave the capacitors in ambient condition for 24±2h before measurement.		
		Voltage proof	No insulation be other damage.	eakdown or	Reflow solder the capacitors on a P.C.Board shown in Appendix 2 beforesting.			
13	Moisture Resistance	External appearance	No mechanical	damage.	Test temp.: 40±2°C Test humidity: 90~95%RH Test time: 500 +24,0h			
	(Steady State)	Capacitance	Characteristics	Change from the value before test	Leave t	he capacitors in amb		
			X7R	Please contact with our sales representative.	Reflow P.C.Boa	2h before measurem solder the capacitor ard shown in Append	s on a	
		D.F.	200% of initial s	pec. max.	testing.	testing.		
		Insulation Resistance	1,000MΩ or 50 whichever small					

(continued)

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No.	lt	em	Perfo	ormance	Test or inspection method	
14	Moisture Resistance	External appearance	No mechanical damage.		Test temp.: 85±2°C Test humidity: 85%RH Applied voltage: Rated voltage	
		Capacitance	Characteristics	Change from the value before test	Test time: 1,000 +48,0h Charge/discharge current:50mA or lower	
			X7R	Please contact with our sales representative.	Leave the capacitors in ambient condition for 24±2h before measurement.	
		D.F.	200% of initial sp	pec. max.	Reflow solder the capacitors on a P.C.Board shown in Appendix2 before testing.	
		Insulation Resistance	500MΩ or 25MΩ·μF min. whichever smaller.		Initial value setting Voltage conditioning 《After voltage treat the capacitors under testing temperature and voltage for 1 hour,》 leave the capacitors in ambient condition for 24±2h before measurement. Use this measurement for initial value.	
15	Life	External appearance	No mechanical damage.		Test temp.: 125±2°C Applied voltage: Please contact with our	
		Capacitance	Characteristics	Change from the value before test	sales representative. Test time: 1,000 +48,0h	
				X7R	Please contact with our sales representative.	Charge/discharge current: 50mA or lower Leave the capacitors in ambient condition for 24±2h before measurement.
		D.F.	200% of initial s	pec. max.	Reflow solder the capacitors on a P.C.Board shown in Appendix2 before testing.	
		Insulation Resistance	1,000MΩ or 50N whichever smal	•	Initial value setting Voltage conditioning 《After voltage treat the capacitors under testing temperature and voltage for 1 hour,》 leave the capacitors in ambient condition for 24±2h before measurement. Use this measurement for initial value.	

^{*}As for the initial measurement of capacitors on number 6,10,11,12 and 13 leave capacitors at 150 0,–10°C for 1 hour and measure the value after leaving capacitors for 24±2h in ambient condition.





(Unit:mm)

Symbol		Dimensions	3
Case size	а	b	С
CEU3 (CC0603)	1.0	3.0	1.2
CEU4 (CC0805)	1.2	4.0	1.65

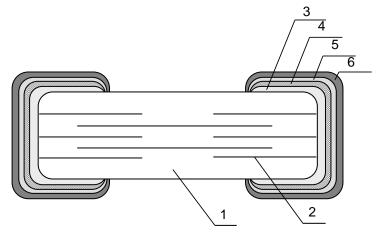
1. Material : Glass Epoxy(As per JIS C6484 GE4)

2. Thickness: 1.6mm

Copper(Thickness:0.035mm)

Solder resist

6. INSIDE STRUCTURE AND MATERIAL



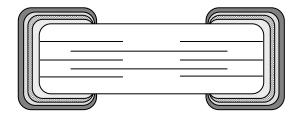
No.	NAME	MATERIAL
1	Dielectric	BaTiO₃
2	Electrode	Nickel (Ni)
3		Copper (Cu)
4	Termination	Conductive resin (Filler : Ag)
5		Nickel (Ni)
6		Tin (Sn)

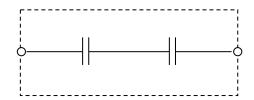
7. CAUTION FOR PRODUCTS WITH SOFT TERMINATION

This product contains Ag (Silver) as part of the middle layer of termination.

To avoid electromigration of Ag under high temperature and humidity, and failures caused by corrosive gas, chip capacitors on P.C boards should be protected by moisture proof-sealing.

8. EQUIVALENT CIRCUIT DIAGRAM





By applying inner electrode patterns divided, this product has the construction which is equivalent to 2 capacitors connected in series. When one side of the serial construction is broken, it helps to reduce the risk of short circuits.

Additionally, soft electrode is applied for the termination. It exhibits a high durability to mechanical stress such as board bending and helps to reduce the risk of short circuits as a result.

This product was developed for a design concept in order to decrease number of short circuits occurrence.

It is not to guarantee the performance to absolutely avoid short circuits.

9. PACKAGING

Packaging shall be done to protect the components from the damage during transportation and storing, and a label which has the following information shall be attached.

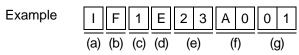
- 9.1 Total number of components in a plastic bag for bulk packaging : 1000pcs
- 9.2 Tape packaging is as per 11. TAPE PACKAGING SPECIFICATION.
 - 1) Inspection No.
 - 2) TDK P/N
 - 3) Customer's P/N
 - 4) Quantity

*Composition of Inspection No.

Example
$$\frac{F}{(a)} \frac{1}{(b)} \frac{A}{(c)} - \frac{23}{(d)} - \frac{001}{(e)}$$

- a) Line code
- b) Last digit of the year
- c) Month and A for January and B for February and so on. (Skip I)
- d) Inspection Date of the month.
- e) Serial No. of the day

(Implemented on and after May 1, 2019 in sequence)



- (a) Prefix
- (b) Line code
- (c) Last digit of the year
- (d) Month and A for January and B for February and so on. (Skip I)
- (e) Inspection Date of the month.
- (f) Serial No. of the day(00 ~ ZZ)
- (g) Suffix($00 \sim ZZ$)

Until the shift is completed, either current or new composition of inspection No. will be applied.

^{*}Composition of new Inspection No.

^{*} It was shifted to the new inspection No. on and after May 2019, but the implementation timing may be different depending on shipment bases.

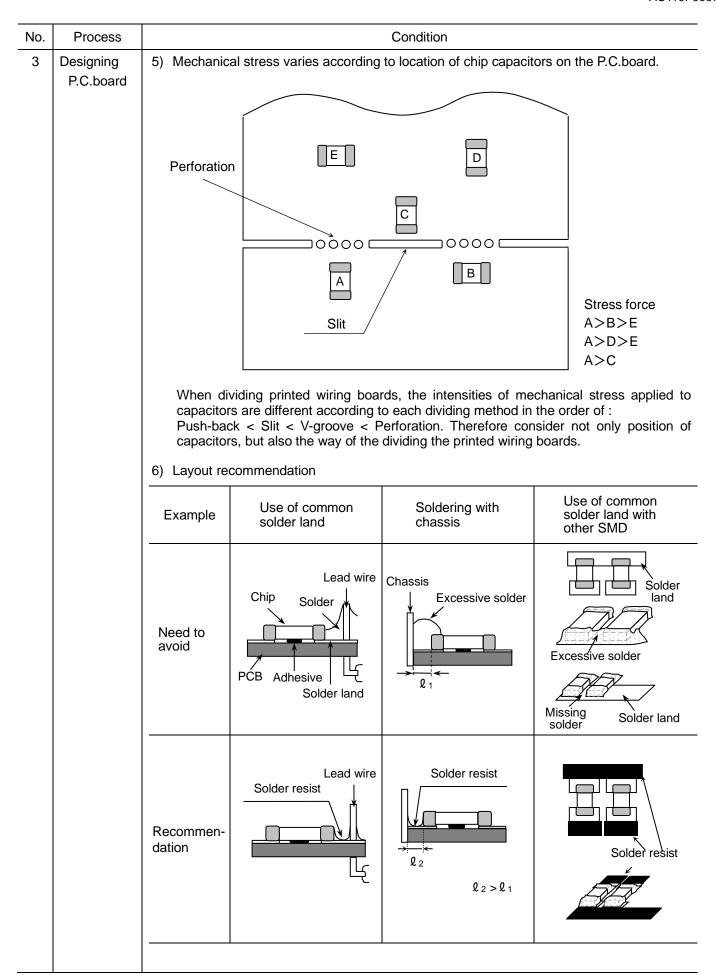
10. CAUTION

	CAUTION					
No.	Process	Condition				
1	Operating Condition (Storage, Use, Transportation)	1-1. Storage, Use The capacitors must be stored in an ambient temperature of 5 to 40°C with a relative humidity of 20 to 70%RH. JIS C 60721-3-1 Class 1K2 should be followed for the other climatic conditions.				
		1) High temperature and humidity environment may affect a capacitor's solder ability because it accelerates terminal oxidization. They also deteriorate performance of taping and packaging. Therefore, SMD capacitors shall be used within 6 months. For capacitors with terminal electrodes consisting of silver or silver-palladium which tend to become oxidized or sulfurized, use as soon as possible, such as within one month after opening the bag.				
		 When capacitors are stored for a longer time period than 6 months, confirm the solderability of the capacitors prior to use. During storage, keep the minimum packaging unit in its original packaging without opening it. Do not deviate from the above temperature and humidity conditions even for a short term. 				
		3) Corrosive gasses in the air or atmosphere may result in deterioration of the reliability, such as poor solderability of the terminal electrodes. Do not store capacitors where they will be exposed to corrosive gas (e.g., hydrogen sulfide, sulfur dioxide, chlorine ammonia etc.)				
		4) Solderability and electrical performance may deteriorate due to photochemical change in the terminal electrode if stored in direct sunlight, or due to condensation from rapid changes in humidity. The capacitors especially which use resin material must be operated and stored in an environment free of dew condensation, as moisture absorption due to condensation may affect the performance.				
		 5) Refer to JIS C 60721-3-1, class 1K2 for other climate conditions. 1-2. Handling in transportation In case of the transportation of the capacitors, the performance of the capacitors may be deteriorated depending on the transportation condition. (Refer to JEITA RCR-2335C 9.2 Handling in transportation) 				
2	Circuit design Caution	 2-1. Operating temperature 1) Upper category temperature (maximum operating temperature) is specified. It is necessary to select a capacitor whose rated temperature us higher than the operating temperature. Also, it is necessary to consider the temperature distribution in the equipment and seasonal temperature variation. 				
		2) Surface temperature including self heating should be below maximum operating				
		temperature. Due to dielectric loss, capacitors will heat itself when AC is applied due to ESR. Especially at high frequencies, please be careful that the heat might be so extreme. Also, even if the surface temperature of the capacitor includes self-heating and is the maximum operating temperature or lower, excessive heating of the capacitor due to self-heating may cause deterioration of the characteristics and reliability of the capacitor.				
		The self-heating temperature rise of the capacitor changes depending on the difference in heat radiation due to the mounting method to the device, the ambient temperature, the cooling method of the device and circuit board material and the design, etc.				
		The load should be contained so that the self-heating temperature rise of the capacitor body in a natural convection environment at an ambient temperature of 25°C remain below 20°C.				
		When using in a high-frequency circuit or a circuit in which a capacitor generates heat, such as when a high-frequency ripple current flows, pay attention to the above precautions. (Note that accurate measurement may not be possible with self-heating measurement when the equipment applies cooling other than natural convection such as a cooling fan.)				
		3) The electrical characteristics of the capacitors will vary depending on the temperature. The capacitors should be selected and designed in taking the temperature into consideration.				

No.	Process	Condition						
2	Circuit design	2-2. When overvoltage is applied						
	Caution	Applying overvol a short circuit. The	Itage to a capacitor	lectric breakdown dep	oreakdown and result in ends on the applied			
	 2-3. Operating voltage 1) Operating voltage across the terminals should be below the rated voltage When AC and DC are super imposed, V_{0-P} must be below the rated voltage. 							
		— (** AC or pulse with overshooting, V _{P-P} must be below the rated voltage. — (3), (** When the voltage is started to apply to the circuit or it is stopped applyin						
			cause of resonance or ge containing these					
		Voltage	(1) DC voltage	(2) DC+AC voltage	(3) AC voltage			
		Positional Measuremen t (Rated voltage)	(O-P)	V _{0-P}	V _{P-P} 0			
		Voltage (4)) Dulas valtara (A)	(E) Dulas valtara (D)				
		Voltage (4	Pulse voltage (A)	(5) Pulse voltage (B)				
		Positional Measuremen t (Rated voltage)	P-P 0	V _{P-P}				
		the reliability of t 3) The effective cap	the capacitors may be pacitance will vary c					
		This product applin series by havin performance mer When one side whatever, it is as	ng inner electrode patt ntioned on specification of the serial constru ssumed that the othe	terns divided. However, on by each side of the so- action is incapable becomer side of serial constru-	o 2 capacitors connected it does not guarantee the erial construction. ause of short circuits or ction will be subjected to circuit design should be			
		in series by one of	capacitor on automot	ive battery line.	o 2 capacitors connected w,) battery line certainly.			
		Abnormal voltage exceed the rates		static electricity, pulse	voltage, etc.) shall not			
		balancing circuit			ssary to add a to avoid an imbalance in			
				used in AC and/or pul and generate audible				

No.	Process	Condition					
3	Designing P.C.board	The amount of solder a capacitors.	at the terminations	has a direct effect or	n the reliability of the		
	1.0.55414	 The greater the amount of solder, the higher the stress on the chip capacitors, and the more likely that it will break. When designing a P.C.board, determine the shape and size of the solder lands to have proper amount of solder on the terminations. 					
		Avoid using common solder land for multiple terminations and provide individual solder land for each terminations.					
		3) Size and recomme	ended land dimensi	ons.			
			Chip cap	acitors Solder land			
		Solder resist					
		Reflow soldering		(mm)			
		Case size	CEU3	CEU4			
		Symbol	(CC0603)	(CC0805)			
		A	0.6 ~ 0.8	0.9 ~ 1.2			
		В	0.6 ~ 0.8	0.7 ~ 0.9			
		C	0.6 ~ 0.8	0.9 ~ 1.2			
		Flow soldering		(mm)			
		Case size Symbol	CEU3 (CC0603)	CEU4 (CC0805)			
		A	0.7 ~ 1.0	1.0 ~ 1.3			
		В	0.8 ~ 1.0	1.0 ~ 1.2			
		C	0.6 ~ 0.8	0.8 ~ 1.1			

No.	Process		Condition	
3	Designing P.C.board	4) Recommende	d chip capacitors layout is as follo	owing.
			Disadvantage against bending stress	Advantage against bending stress
		Mounting face	Perforation or slit Break P.C.board with	Perforation or slit Break P.C.board with mounted side down.
			mounted side up. Mount perpendicularly to	Mount in parallel with
		Chip arrangement (Direction)	Perforation or slit	Perforation or slit
		Distance from slit	Closer to slit is higher stress (l1 < l2)	Away from slit is less stress



No.	Process		C	Condition				
4	Mounting	_	-	-	duce excessive stress in the chiping precautions.			
		Adjust the bott surface and no	ead to reach on the P.C.board					
		2) Adjust the mou	inting head pressure	to be 1 to 3N	I of static weight.			
		support from the	To minimize the impact energy from mounting head, it is important to provide support from the bottom side of the P.C.board. See following examples.					
			Not recomme	ended	Recommended			
		Single-sided mounting		- Crack	A support pin is not to be underneath the capacitor.			
		Double- sides mounting	Solder peeling Cra	ack	Support pin			
		to cause crack.		se up dimen	Lechanical impact on the capacitor sion of the centering jaw and lacement of it.			
		4-2. Amount of adl	nesive					
				a b				
				c c				
			<u> </u>					
			21		805)			
			Example :	CEU4 (CC08	<u> </u>			
			21		in.			

No.	Process	Condition				
5	Soldering	5-1. Flux selection Flux can seriously affect the performance of capacitors. Confirm the following to select the appropriate flux.				
		 It is recommended to use a mildly activated rosin flux (less than 0.1wt% chlorine). Strong flux is not recommended. Excessive flux must be avoided. Please provide proper amount of flux. When water-soluble flux is used, enough washing is necessary. 				
	5-2. Recommended soldering profile: Reflow method Refer to the following temperature profile at Reflow soldering.					
		Reflow soldering				
		Soldering Preheating Natural cooling				
	5-3 Reco	Peak Temp time 5-3. Recommended soldering peak temp and peak temp duration for Reflow soldering				
		Pb free solder is recommended, but if Sn-37Pb must be used, refer to below. Temp./Duration				
		Reflow soldering				
		Solder Peak temp(°C) Duration(sec.)				
		Lead Free Solder 260 max. 10 max.				
		Sn-Pb Solder 230 max. 20 max.				
		Recommended solder compositions Lead Free Solder : Sn-3.0Ag-0.5Cu				

No.	Process		Condition					
5	Soldering	5-4. Soldering profile: Flow method (Unrecommend) Refer to the following temperature profile at Flow soldering.						
		Flow soldering						
		Preheating	Soldering Natural co	oling -				
		Peak Temp (Q) Over 60 sec. Peak Temp time Reflow soldering is recommended. 5-5. Recommended soldering peak temp and peak temp duration for Flow soldering						
		Pb free solder is recommended, but if Sn-37Pb must be used, refer to below.						
		Temp./Duration	Idering					
		Solder	Peak temp(°C)	Duration(sec.)				
		Lead Free Solder	260 max.	5 max.				
		Sn-Pb Solder	250 max.	3 max.				
		Recommended solder compos Lead Free Solder : Sn-3.0Ag-						
		5-6. Avoiding thermal shock						
		Preheating condition						
		Soldering	Temp. (°C)					
		Reflow soldering	$\Delta T \leq 150$					
		Flow soldering	ΔT ≦ 150					
		Cooling condition Natural cooling using air is recolleraning, the temperature difference of the cooling condition.		ips are dipped into a solvent for less than 100°C.				

No.	Process	Condition
5	Soldering	5-7. Amount of solder Excessive solder will induce higher tensile force in chip capacitors when temperature changes and it may result in chip cracking. In sufficient solder may detach the capacitors from the P.C.board.
		Excessive solder Higher tensile force in chip capacitors to cause crack
		Adequate Maximum amount Minimum amount
		Insufficient solder Low robustness may cause contact failure or chip capacitors come off the P.C.board.
	Sn-Zn solder at Please contact 5-9. Countermeas The misalignme patterns should the capacitors a reflow soldering (Refer to JEITA	5-8. Sn-Zn solder Sn-Zn solder affects product reliability. Please contact TDK in advance when utilize Sn-Zn solder. 5-9. Countermeasure for tombstone The misalignment between the mounted positions of the capacitors and the land patterns should be minimized. The tombstone phenomenon may occur especially the capacitors are mounted (in longitudinal direction) in the same direction of the reflow soldering. (Refer to JEITA RCR-2335C Annex A (Informative), Recommendations to prevent the tombstone phenomenon.)

No.	Process		Con	dition				
6	Solder repairing		Solder repairing is unavoidable, refer to below. 6-1. Solder repair by solder iron					
		1) Selection of the soldering iron tip Tip temperature of solder iron varies by its type, P.C.board material and solder land size. The higher the tip temperature, the quicker the operation. However, heat shock may cause a crack in the chip capacitors. Please make sure the tip temp. before soldering and keep the peak temp and time in accordance with following recommended condition.						
		Manual soldering (Solder iron)						
		Peak Temp () c) cdue P	ΔT	ng				
		3sec. (As short as possible)						
		Recommended solder iron condition (Sn-Pb Solder and Lead Free Solder)						
		Temp. (°C)	Duration (sec.)	Wattage (W)	Shape (mm)			
		350 max.	3 max.	20 max.	Ø 3.0 max.			
		* Please preheat the chi	p capacitors with th	e condition in 6-2 to a	avoid the thermal shock.			
			touch the ceramic		hip capacitors may ninations by solder iron.			
		6-2. Avoiding thermal shock						
		Preheating condition						
		Solder	ing 7	emp. (°C)				
		Manual so	Idering 2	AT ≦ 150				

No.	Process	Condition
7	Cleaning	If an unsuitable cleaning fluid is used, flux residue or some foreign articles may stick to chip capacitors surface to deteriorate especially the insulation resistance.
		2) If cleaning condition is not suitable, it may damage the chip capacitors.
		2)-1. Insufficient washing (1) Terminal electrodes may corrode by Halogen in the flux.
		(2) Halogen in the flux may adhere on the surface of capacitors, and lower the
		insulation resistance.
		(3) Water soluble flux has higher tendency to have above mentioned problems (1) and (2).
		2)-2. Excessive washing
		When ultrasonic cleaning equipment is used, excessive ultrasonic power or direct vibration transfer to a printed wiring board may generate a resonant vibration in the board. This may cause a crack in a capacitor or its solder joints to the board and degradation in the terminal strength of the capacitor. In order to avoid this, the following cleaning conditions are recommended.
		Power : 20 W/l max.
		Frequency : 40 kHz max.
		Washing time: 5 minutes max.
		2)-3. If the cleaning fluid is contaminated, density of Halogen increases, and it may bring the same result as insufficient cleaning.
8	Coating and molding of the P.C.board	This product contains Ag (Silver) as part of the middle layer of termination. To avoid electromigration of Ag under high temperature and humidity, and failures caused by corrosive gas, chip capacitors on P.C boards should be protected by moisture proof-sealing.
		2) When the P.C.board is coated, please verify the quality influence on the product.
		Please verify carefully that there is no harmful decomposing or reaction gas emission during curing which may damage the chip capacitors.
		4) Please verify the curing temperature.
9	Handling after chip mounted Caution	Please pay attention not to bend or distort the P.C.board after soldering in handling otherwise the chip capacitors may crack. Thirt
	<u> </u>	Bend Twist

No.	Process	Condition						
9	Handling after chip mounted Caution	 2) Printed circuit board cropping should not be carried out by hand, but by using the proper tooling. Printed circuit board cropping should be carried out using a board cropping jig as shown in the following figure or a board cropping apparatus to prevent inducing mechanical stress on the board. (1)Example of a board cropping jig Recommended example: The board should be pushed from the back side, close to the cropping jig so that the board is not bent and the stress applied to the capacitor is compressive. Unrecommended example: If the pushing point is far from the cropping jig and the pushing direction is from the front side of the board, large tensile stress is applied to the capacitor, which may cause cracks. 						
		Outline of jig		Recommende	ed	Unrecommend	ed	
		Printed circuit board V-groove Slot Slo						
		(2)Example of a board cropping machine An outline of a printed circuit board cropping machine is shown below. The top and bottom blades are aligned with one another along the lines with the V-grooves on printed circuit board when cropping the board. Unrecommended example: Misalignment of blade position between top a bottom, right and left, or front and rear blades may cause a crack in the capacitor.						
		Outline of machine Principle of operation						
Printed circuit board V-groove Bot					Bottom blade DSS-Section Top blace]		
		Recommended						
				Top-bottom misalignment	Left-right misalignment	Front-rear misalignment		
		Board Board Bottom bla	\supseteq	Top blade	Top blade	Top blade Bottom blade		

No.	Process		Condition					
9	Handling after chip mounted Caution	3) When functional check of the P.C.board is performed, check pin pressure tends to be adjusted higher for fear of loose contact. But if the pressure is excessive and bend the P.C.board, it may crack the chip capacitors or peel the terminations off. Please adjust the check pins not to bend the P.C.board.						
		Item Not recommended Recommended						
		Board bending	Termination peeling Check pin	Support pin Check pin				
10	Handling of loose chip capacitors	1) If dropped the chip capacitors may crack. Once dropped do not use it. Especially, the large case sized chip capacitors are tendency to have cracks easily, so please handle with care. Crack P.C. board may hit the chip capacitors of another board to cause crack.						
11	Capacitance aging	The capacitors (Class 2) have aging in the capacitance. They may not be used in precision time constant circuit. In case of the time constant circuit, the evaluation should be done well.						
12	Estimated life and estimated failure rate of capacitors	and the volta RCR-2335C estimated fail Temperature The failure ra	timated life and the estimated failur ge. This can be calculated by the ed Annex F (Informative) Calculation of ure rate (Voltage acceleration coef acceleration coefficient: 10°C rule) te can be decreased by reducing the pe guaranteed.	quation described in JEITA If the estimated lifetime and the Ifficient: 3 multiplication rule,				

No.	Process	Condition
13	Caution during operation of equipment	A capacitor shall not be touched directly with bare hands during operation in order to avoid electric shock. Electric energy held by the capacitor may be discharged through the human body when touched with a bare hand. Even when the equipment is off, a capacitor may stay charged. The capacitor should be handled after being completely discharged using a resistor.
		2) The terminals of a capacitor shall not be short-circuited by any accidental contact with a conductive object. A capacitor shall not be exposed to a conductive liquid such as an acid or alkali solution. A conductive object or liquid, such as acid and alkali, between the terminals may lead to the breakdown of a capacitor due to short circuit
		 Confirm that the environment to which the equipment will be exposed during transportation and operation meets the specified conditions. Do not to use the equipment in the following environments. Environment where a capacitor is spattered with water or oil Environment where a capacitor is exposed to direct sunlight Environment where a capacitor is exposed to Ozone, ultraviolet rays or radiation Environment where a capacitor exposed to corrosive gas(e.g. hydrogen sulfide, sulfur dioxide, chlorine. ammonia gas etc.) Environment where a capacitor exposed to vibration or mechanical shock exceeding the specified limits. Atmosphere change with causes condensation
14	Others Caution	The product listed in this specification is intended for use in automotive applications under-normal operation and usage conditions.
		The product is not designed or warranted to meet the requirements of application listed below, whose performance and/or quality requires a more stringent level of safety or reliability, or whose failure, malfunction or defect could cause serious damage to society, person or property. Please understand that we are not responsible for any damage or liability caused by use of the products in any of the applications below or for any other use exceeding the range or conditions set forth in this specification sheet. If you intend to use the products in the applications listed below or if you have special requirements exceeding the range or conditions set forth in this specification, please contact us.
		 (1) Aerospace/Aviation equipment (2) Transportation equipment (electric trains, ships etc.) (3) Medical equipment (Excepting Pharmaceutical Affairs Law classification Class1, 2) (4) Power-generation control equipment (5) Atomic energy-related equipment (6) Seabed equipment (7) Transportation control equipment (8) Public information-processing equipment (9) Military equipment (10) Electric heating apparatus, burning equipment (11) Disaster prevention/crime prevention equipment (12) Safety equipment (13) Other applications that are not considered general-purpose applications
		When designing your equipment even for general-purpose applications, you are kindly requested to take into consideration securing protection circuit/device or providing backup circuits in your equipment. In addition, although the product listed in this specification is intended for use in automotive applications as described above, it is not prohibited to use for general electronic equipment, whose performance and/or quality doesn't require a more stringent level of safety or reliability, or whose failure, malfunction or defect could not cause serious damage to society, person or property. Therefore, the description of this caution will be applied, when the product is used in general electronic equipment under a normal operation and usage conditions.

11. TAPE PACKAGING SPECIFICATION

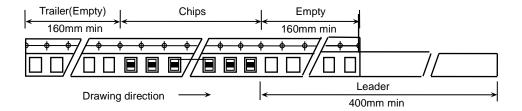
1. CONSTRUCTION AND DIMENSION OF TAPING

1-1. Dimensions of carrier tape

Dimensions of paper tape shall be according to Appendix 3.

Dimensions of plastic tape shall be according to Appendix 4.

1-2. Bulk part and leader of taping

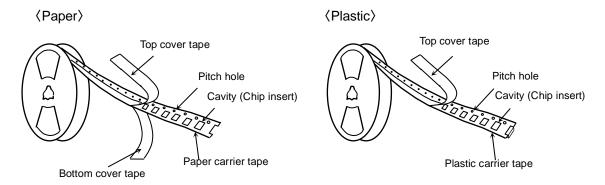


1-3. Dimensions of reel

Dimensions of Ø178 reel shall be according to Appendix 5.

Dimensions of Ø330 reel shall be according to Appendix 6.

1-4. Structure of taping



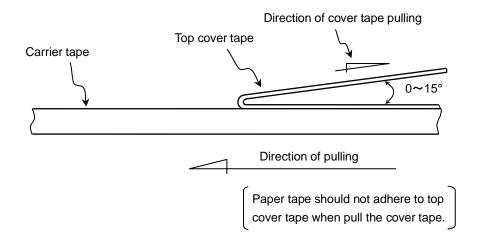
2. CHIP QUANTITY

Please refer to detail page on TDK web.

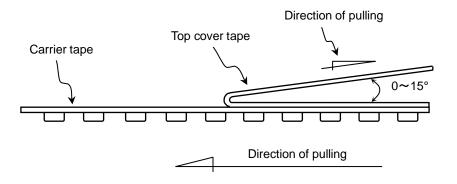
3. PERFORMANCE SPECIFICATIONS

3-1. Fixing peeling strength (top tape)0.05N < Peeling strength < 0.7N

⟨Paper⟩



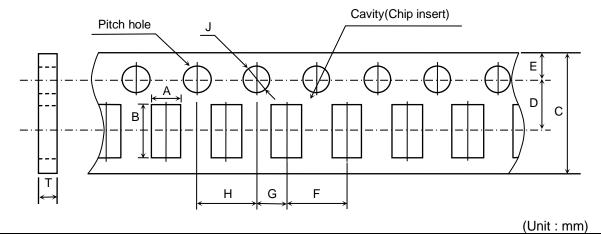
⟨Plastic⟩



- 3-2. Carrier tape shall be flexible enough to be wound around a minimum radius of 30mm with components in tape.
- 3-3. The missing of components shall be less than 0.1%
- 3-4. Components shall not stick to fixing tape.
- 3-5. When removing the cover tape, there shall not be difficulties by unfitting clearance gap, burrs and crushes of cavities. Also the sprocket holes shall not be covered by absorbing dust into the suction nozzle.

Appendix 3

Paper Tape

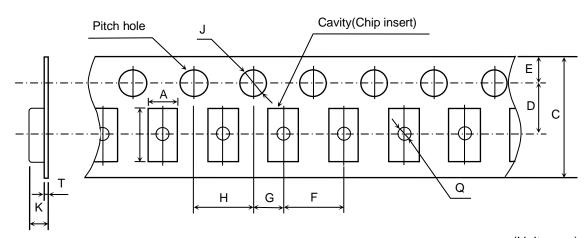


						(01111.11111)
Symbol Case size	А	В	С	D	E	F
CEU3 (CC0603)	(1.10)	(1.90)	8.00 ± 0.30	3.50 ± 0.05	1.75 ± 0.10	4.00 ± 0.10
Symbol Case size	G	Н	J	Т		
CEU3 (CC0603)	2.00 ± 0.05	4.00 ± 0.10	Ø 1.5 ^{+0.10} ₀	1.20 max.		

) Reference value.

Appendix 4

Plastic Tape

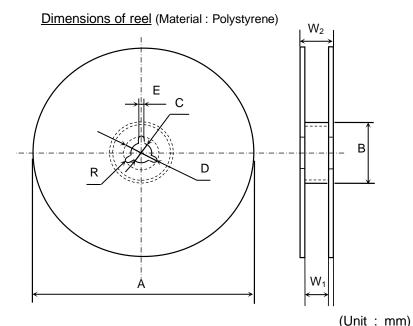


						(Unit : mm)
Symbol Case size	А	В	С	D	E	F
CEU4 (CC0805)	(1.50)	(2.30)	8.00 ± 0.30	3.50 ± 0.05	1.75 ± 0.10	4.00 ± 0.10
Symbol Case size	G	Н	J	K	Т	Q
CEU4 (CC0805)	2.00 ± 0.05	4.00 ± 0.10	Ø 1.5 ^{+0.10} ₀	2.50 max.	0.30 max.	Ø 0.50 min.

⁾ Reference value.

Exceptionally no hole in the cavity is applied. Please inquire if hole in cavity is mandatory.

Appendix 5

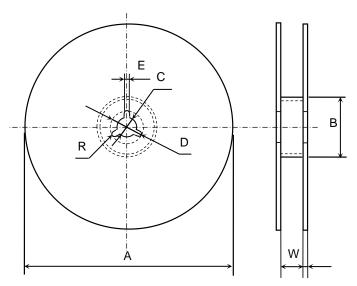


Symbol	А	В	С	D	E	W ₁
Dimension	Ø178 ± 2.0	Ø60 ± 2.0	Ø13 ± 0.5	Ø21 ± 0.8	2.0 ± 0.5	9.0 ± 0.3

Symbol	W_2	R
Dimension	13.0 ± 1.4	1.0

Appendix 6

<u>Dimensions of reel</u> (Material : Polystyrene)



(Unit: mm)

Symbol	А	В	С	D	E	W
Dimension	Ø382 max. (Nominal Ø330)	Ø50 min.	Ø13 ± 0.5	Ø21 ± 0.8	2.0 ± 0.5	10.0 ± 1.5

Symbol	t	R
Dimension	2.0 ± 0.5	1.0